

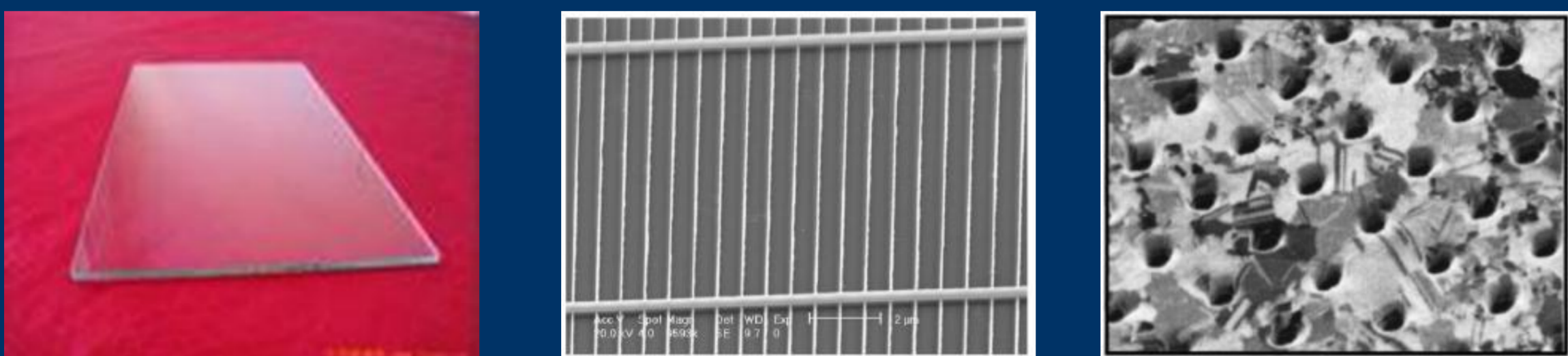
Zhengyong Song<sup>1</sup>, Qiong He<sup>1</sup>, Radu Malureanu<sup>2</sup>, Maksim Zalkovskij<sup>2</sup>,  
Andrei V. Lavrinenko<sup>2</sup>, and Lei Zhou<sup>1\*</sup>

<sup>1</sup>State Key Laboratory of Surface Physics and Key Laboratory of Micro and Nano Photonic Structures (Ministry of Education), Fudan University, Shanghai, 200433, China

<sup>2</sup>Department of Photonics Engineering, Technical University of Denmark, Kgs. Lyngby 2800, Denmark  
\*phzhou@fudan.edu.cn

## Backgrounds:

Transparent conducting metals (TCMs) are highly desired due to numerous applications, such as solar cells, displays, and so on.



Indium Tin Oxide

Nano-Meshes

EOT

**PROBLEMS:** Available approaches sacrifice metal's conductance and are sensitive to structural disorder

## Motivation:

- An apertureless TCM with perfect conductivity
- High transmittance
- Robust against structural disorder
- Wide-angle response

## III. Proof-of-concept experiments

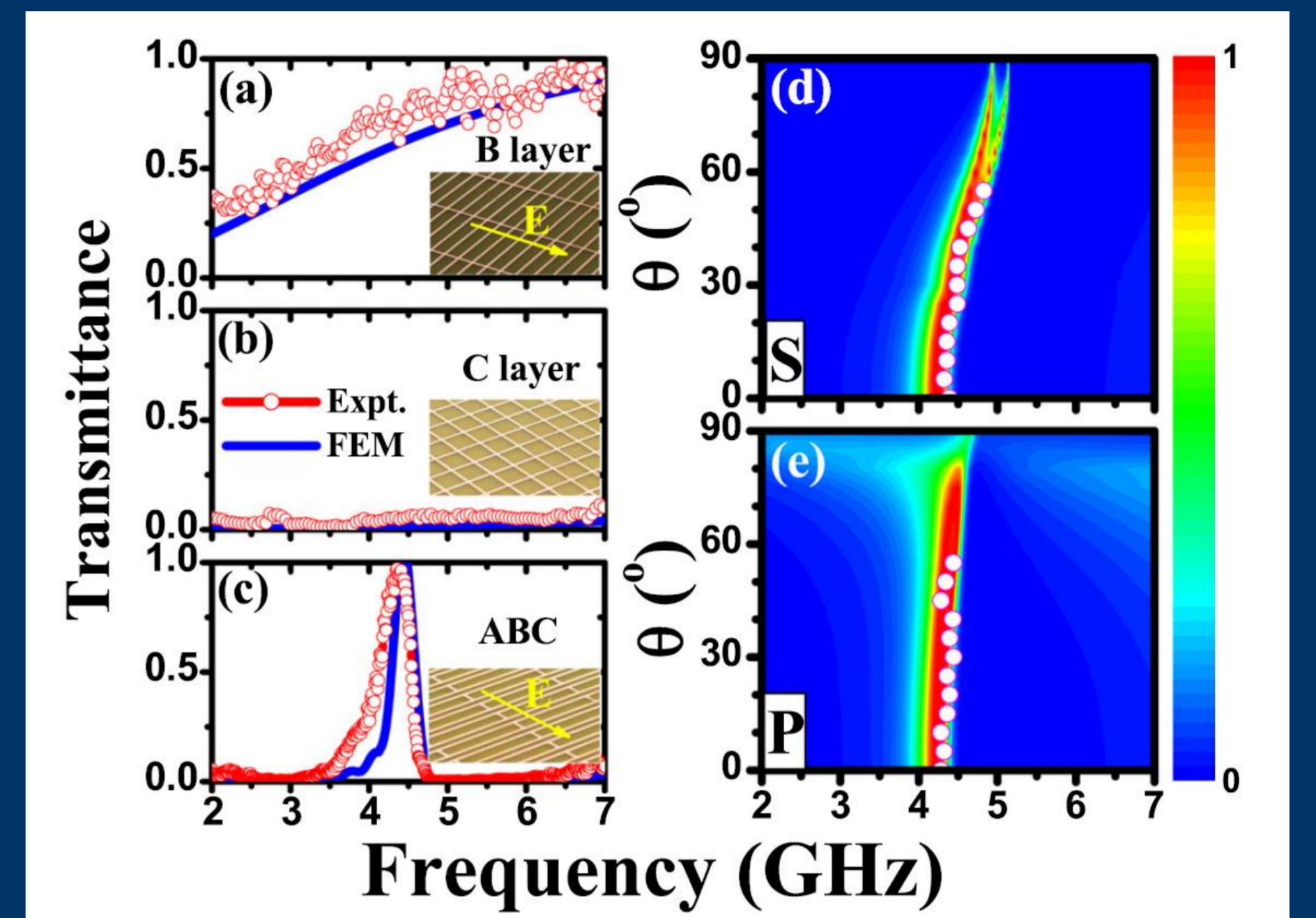


Fig. 4 Measured and simulated transmittance of designed sample at microwave region

- Metallic meshes mimic plasmonic metal in GHz
- Experiments agree well with simulations
- Insensitive to incidence angles

## IV. TCM on substrate

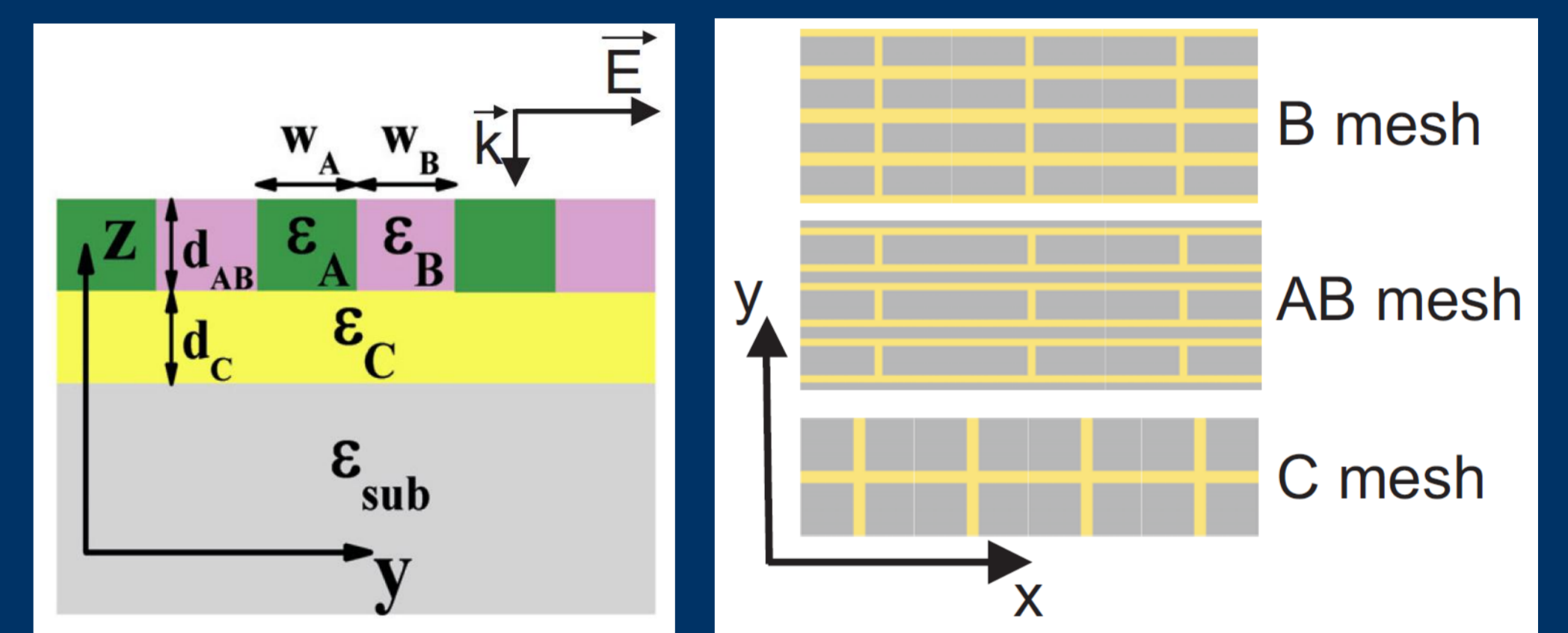


FIG. 5 TCM design on semi-infinite substrate and sample fabricated in Terahertz

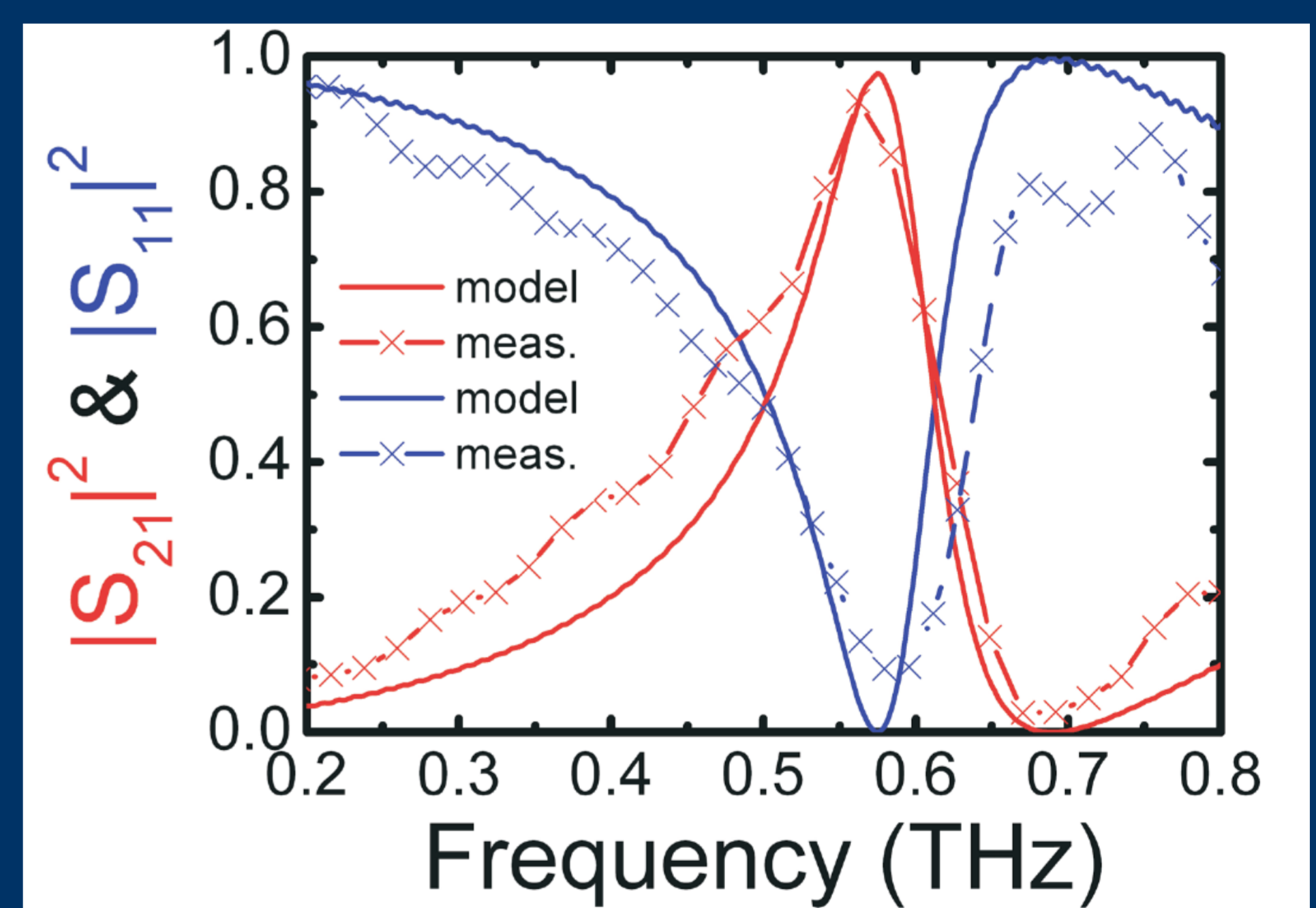


FIG. 6 Measured and simulated transmission and reflection spectrums on THz TCM

- Great agreement between experiments and simulations

## Conclusions:

- SCM make a continuous metal film transparent at optical frequency
- Experimental demonstrations at GHz and THz regions
- Robustness against incident angle and structure disorder

## I. Concept

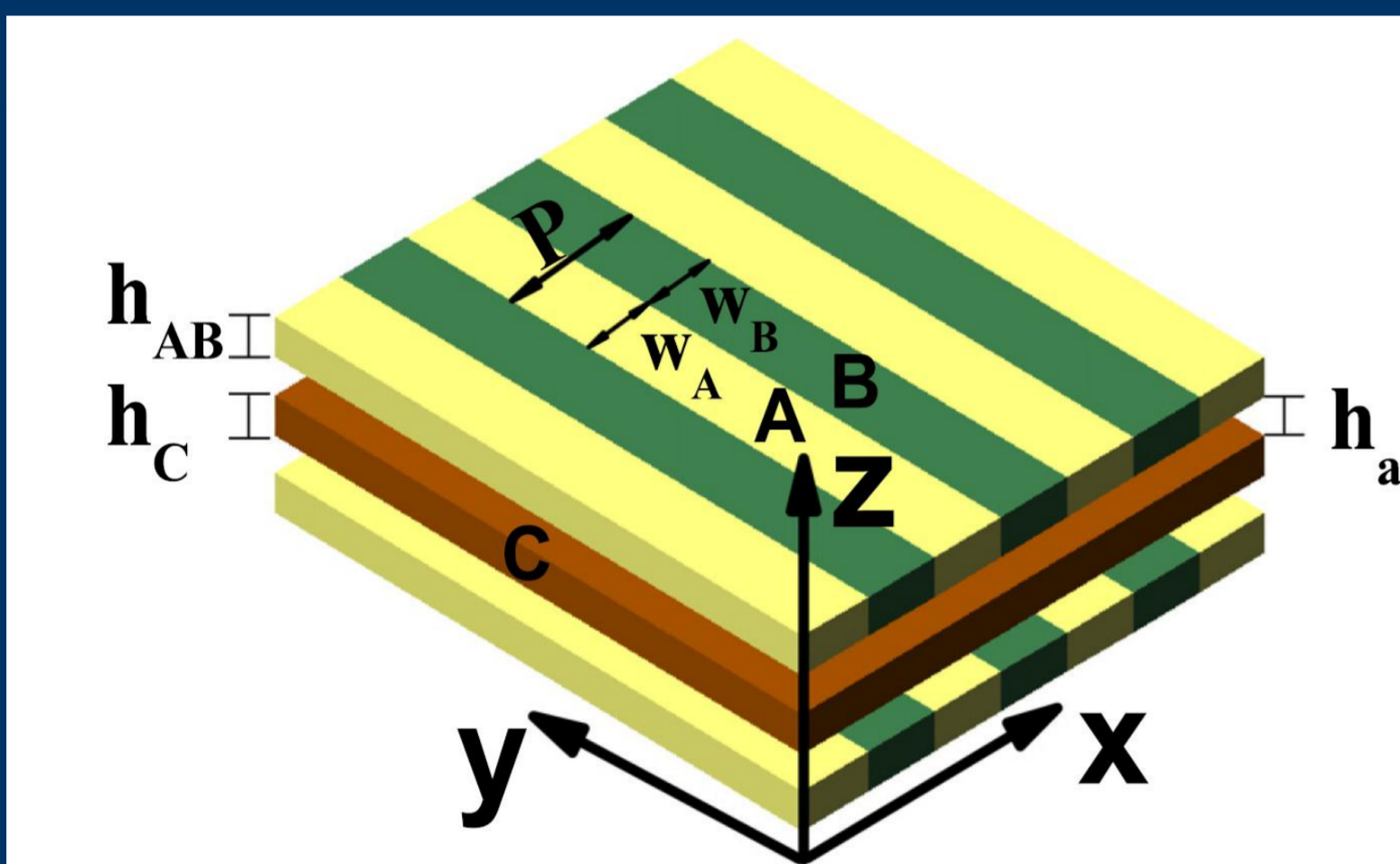


Fig. 1 Geometry of designed TCM structure

Layer C: metal film

Layer AB: dielectric(A) and metallic stripes (B)

## Analytical solutions

- Mode expansion theory
- Two approximations: only consider zero-order mode and fundamental Bloch mode in air region and inside AB layers, respectively
- $P \ll \lambda$ , and  $h_C, h_a \ll \lambda$
- Material's loss neglected

## Perfect transparency condition

reflection from AB

reflection from C

$$\left( \frac{Z_0}{Z_{AB}} - \frac{Z_{AB}}{Z_0} \right) 2 \tan(k_{AB}^z h_{AB}) - \left( \frac{a_C}{k_0} - \frac{k_0}{a_C} \right) 2 \tan(a_C \bar{h}_C) - \left( \frac{a_C Z_{AB}^2}{k_0 Z_0^2} - \frac{k_0 Z_0^2}{a_C Z_{AB}^2} \right) \tan^2(k_{AB}^z h_{AB}) \tan(a_C \bar{h}_C) = 0$$

Multiple scattering effects

## Scattering cancellation mechanism (SCM)

- Tuning  $Z_{AB}$  efficiently by adjusting AB structure
- $Z_{AB}$  makes reflection from AB layer strong enough to cancel the one from C layer

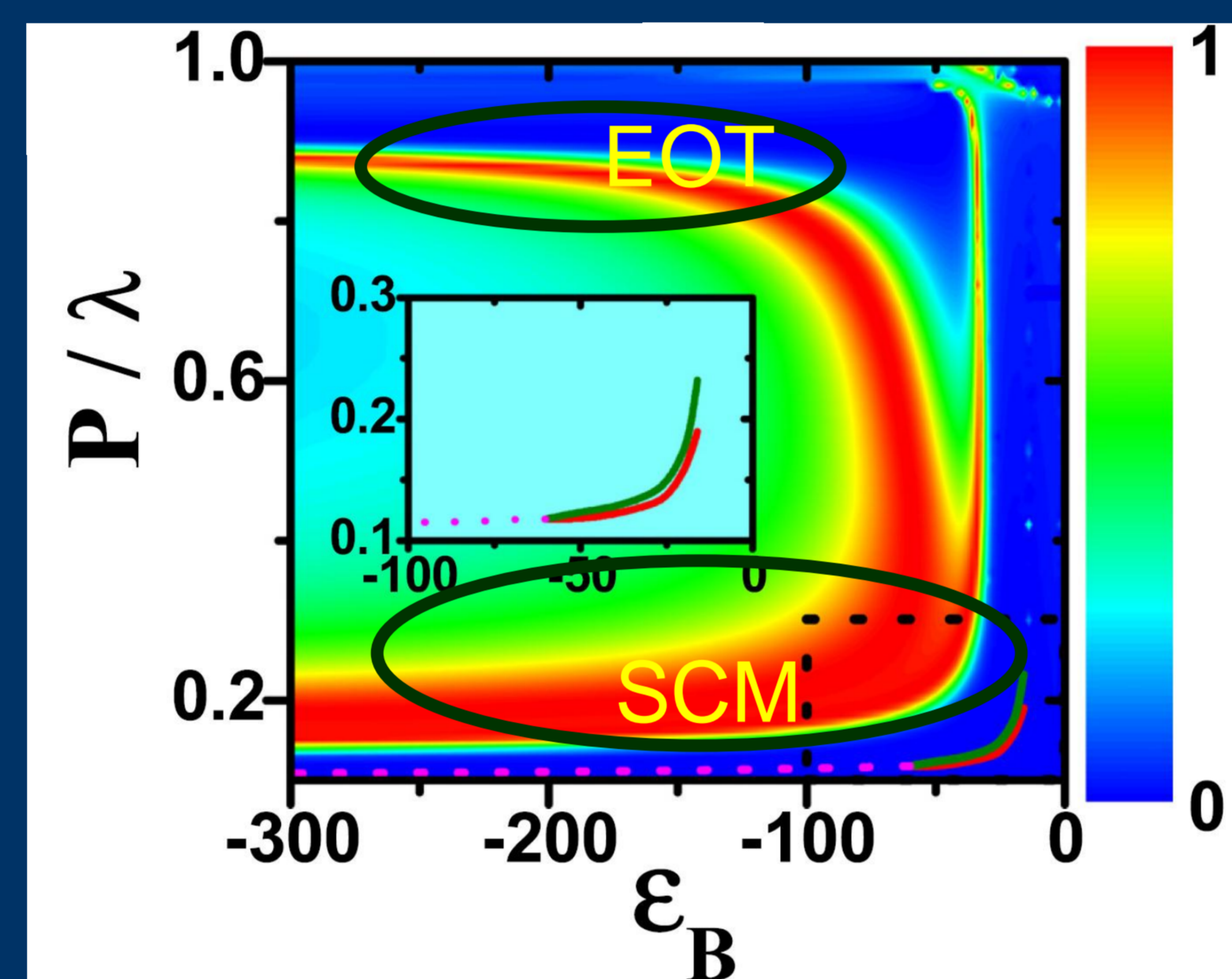


Fig. 2 FEM simulation on transmittance as functions of  $P/\lambda$  and  $\epsilon_B$ , with  $\epsilon_C = -110$ ,  $\epsilon_a = 1$ ,  $\epsilon_A = 12$ ,  $h_{AB} = h_C = 2h_a = 0.02\lambda$ ,  $w_B = 0.1\lambda$

- **Broad** SCM transmission band
- **Independent** on  $P$  in the region of  $-90 < \epsilon_B < -30$
- **Robust** against structure disorder

## II. Optical TCM design

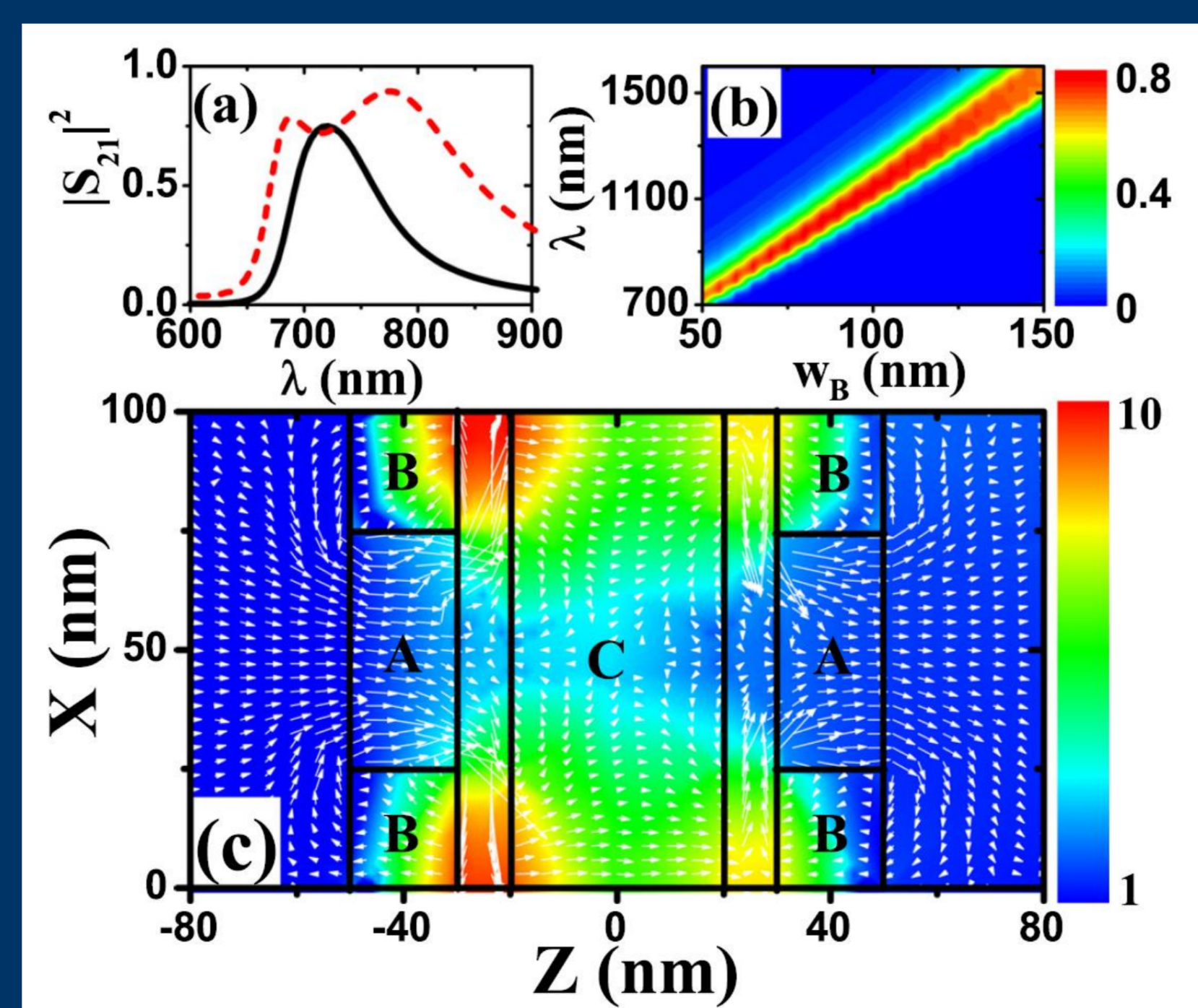


Fig.3 FEM simulation of realistic designs based on Ag films

- **75% and 90%** transmittance for Ag films ( $h_C = 40$  and  $25$ nm) at  $700$  and  $776$ nm, respectively
- **Tunability** of transmission peaks via changing  $w_B$

## References:

- [1] Zhengyong Song, et al., Appl. Phys. Lett. **101**, 181110 (2012).
- [2] Radu Malureanu, et al., Opt. Express **20**, 22770 (2012).